SDI321618 SERIES

1. PART NO. EXPRESSION:

<u>SDI321618</u>-<u>R12M</u>F

(a) Series code

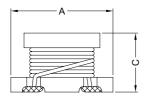
(d) Tolerance code : $J = \pm 5\%$, $K = \pm 10\%$, $M = \pm 20\%$

(a) (b) (c) (d)(e)

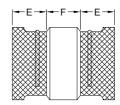
(b) Dimension code (e) F: Lead Free

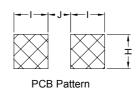
(c) Inductance code: R12 = 0.12uH

2. CONFIGURATION & DIMENSIONS:









Unit:m/m

	Α	В	С	E	F	Н	I	J
3.	2±0.3	1.6±0.2	1.8±0.3	0.7 Min.	0.7 Min.	1.5 Ref.	1.5 Ref.	1.0 Ref.

3. SCHEMATIC:



4. GENERAL SPECIFICATION:

a) Ambient temp. : 20°C

b) Operating temp. : -25°C to 85°C

c) Rated current : Base on temp. rise & ΔL/L0A=10% Max.



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5. ELECTRICAL CHARACTERISTICS:

Part No.	Inductance (uH)	Tolerance	Test Frequency (Hz)	SRF (MHz) Min.	DCR (Ω) Max.	IDC (mA) Max.
SDI321618-R12 F	0.12	M	1M	250	0.112	970
SDI321618-R22 F	0.22	М	1M	250	0.140	850
SDI321618-R47 F	0.47	M	1M	180	0.210	700
SDI321618-1R0 F	1.0	M	1M	100	0.364	510
SDI321618-2R2 F	2.2	M	1M	50	0.533	430
SDI321618-4R7 F	4.7	K, M	1M	31	0.845	340
SDI321618-100 F	10	J, K	1M	20	1.690	230
SDI321618-220 F	22	J, K	1M	14	3.900	160
SDI321618-470 F	47	J, K	1M	10	10.40	100
SDI321618-101 F	100	J, K	1M	7.0	15.60	80

Tolerance code:

: J = ±5%

 $K = \pm 10\%$

 $M = \pm 20\%$



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6. RELIABILITY AND TEST CONDITION:

ITEM	PERFORMANCE	TEST CONDITION		
Environmental Tests				
High Temperature Storage Test Reference documents: MIL-STD-202G Method 108A	No case deformation or change in appearance. ΔL/L≤30% (Closed Magnetic Circuit) ΔL/L≤10% ΔQ/Q ≤ 30% ΔDCR/DCR≤10%	Temperature : 85±2°C Time : 96±2 hours Tested after 1 hour (less than 2 hours) at room temperature Temp 85°C High temperature 1H 96H Test Time		
Low Temperature Storage Test Reference documents: IEC 68-2-1A 6.1 6.2	 No case deformation or change in appearance. ΔL/L≤30% (Closed Magnetic Circuit) ΔL/L≤10% ΔQ/Q ≤ 30% ΔDCR/DCR≤10% 	Temperature : -25±2°C Time : 96±2 hours Tested after 1 hour (less than 2 hours) at room temperature Room Temp 0 -25°C Low temperature Time		
Humidity Test Reference documents: MIL-STD-202G Method 103B	No case deformation or change in appearance. ΔL/L≤30% (Closed Magnetic Circuit) ΔL/L≤10% ΔQ/Q ≤ 30% ΔDCR/DCR≤10%	Dry oven at temperature of 40±5°C for 24 hours Measured after 24 hours Exposure: Temperature: 40±2°C, Humidity: 93±3% RH,		
Thermal shock test Reference documents: MIL-STD-202G Method 107G	1. No case deformation or change in appearance. 2. ΔL/L≤30% (Closed Magnetic Circuit) ΔL/L≤10% 3. ΔQ/Q ≤ 30% 4. ΔDCR/DCR≤10% T: weight≤ 28g: 15 Min. 28g≤weight≤136g: 30 Min.	Conditions of 1 cycle: Step 1: -40°C for T time Step 2: 125°C for T time Total: 20 cycles Temp Change time < 5 min 125°C Room Temp 0 40°C T Time		
Physical Characteristics Test	S			
Solderability Test Reference documents: MIL-STD-202G Method 208H IPC J-STD-002B	More than 95% of termincal electrode should be covered with solder.	Solder temperature : 245±5°C Dip time : 5 secs. Solder : Sn(63)/Pb(37) Flux : rosin flux		

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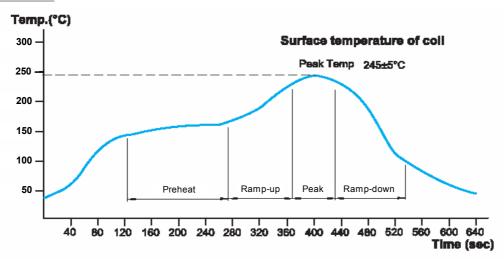
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6. RELIABILITY AND TEST CONDITION:

ITEM	PERFO	RMANC	E	TEST CONDITION		
Heat Endurance of Reflow Soldering Reference documents: IPC J-STD-020B	1. No case deformation 2. ΔL/L≤30% (Closed ΔL/L≤10%) 3. ΔQ/Q≤30% 4. ΔDCR/DCR≤10%	•		Refer to reflow curve. No. of cycle: 3 Peak temp.: 245±5°C		
Vibration Test Reference documents: MIL-STD-202G Method 201A	1. No case deformation 2. ΔL/L≤30% (Closed ΔL/L≤10% 3. ΔQ/Q≤30% 4. ΔDCR/DCR≤10%	•		Frequency: 10~55Hz Amplitude: 0.75mm Directions & times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).		
Drop Test Reference documents: MIL-STD-202G Method 203C	 No case deformation or change in appearance. ΔL/L≤30% (Closed Magnetic Circuit) ΔL/L≤10% ΔQ/Q≤30% ΔDCR/DCR≤10% 			Drop from a height of 1m with 981m/s² (100G) altitude (1 angle, 1 ridge and 2 surface orientations)		
Terminal Strength Push Test Reference documents: JIS C 5321:1997	A : Sectional area of terminal Force Time (sec)		Bend PCB at middle point, the deflection shall be 2mm. Pulling Test: X Bending Test: R0.5 Sample			

Reflow Curve



Pb

RoHS Compliant

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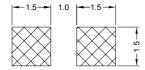


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7. SOLDERING AND MOUNTING:

7-1. Recommended PC Board Pattern



7-2. Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. Our terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

7-2.1 Solder Re-flow:

Recommended temperature profiles for re-flow soldering in Figure 1.

7-2.2 Solder Wave:

Wave soldering is perhaps the most rigorous of surface mount soldering processes due to the steep rise in temperature seen by the circuit when immersed in the molten solder wave, typical at 240°C. Due to the risk of thermal damage to products, wave soldering of large size products is discouraged. Recommended temperature profile for wave soldering is shown in Figure 2.

7-2.3 Soldering Iron (Figure 2):

Products attachment with soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

Note:

- a) Preheat circuit and products to 150°C.
- b) 280°C tip temperature (max)
- c) Never contact the ceramic with the iron tip
- d) 1.0mm tip diameter (max)
- e) Use a 20 watt soldering iron with tip diameter of 1.0mm
- f) Limit soldering time to 3 secs.

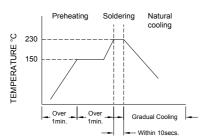


Figure 1. Re-flow Soldering

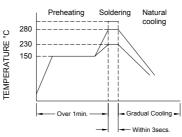


Figure 3. Hand Soldering

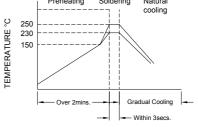


Figure 2. Wave Soldering



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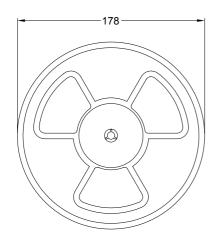


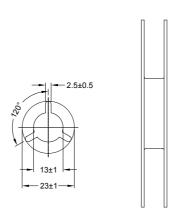
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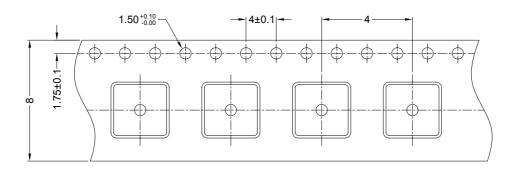
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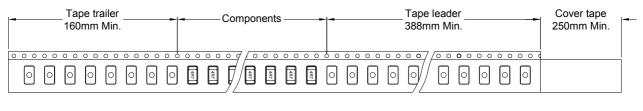
8. PACKAGING INFORMATION: (Unit:mm)

8-1. Reel & Tape Dimension









Direction of feed

8-2. Quantity & G.W. per package

	INNER :	REEL	OUTER : CARTON			
SERIES	Q'TY (PCS)	G.W. (Kg)	Q'TY (PCS)	G.W. (Kg)	SIZE (cm)	
SDI321618	2000	0.13	120000	12	39 x 39 x 23	



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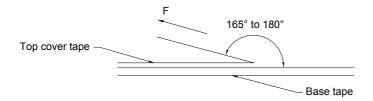
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8-3. Tearing Off Force



The force for tearing off cover tape is 10 to 60 grams in the arrow direction.

Application Notice

1. Storage Conditions:

To maintain the solderability of terminal electrodes :

- a) Temperature and humidity conditions: Less than 40°C and 70% RH.
- b) Recommended products should be used within 6 months from the time of delivery.
- c) The packaging material should be kept where no chlorine or sulfur exists in the air.

2. Transportation:

- a) Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- b) The use of tweezers or vacuum pick up is strongly recommended for individual components.
- c) Bulk handling should ensure that abrasion and mechanical shock are minimized.



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